Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/812,419	LEE ET AL.	
Examiner	Art Unit	
James Cho	2819	

SEARCHED						
Class	Subclass	Date	Examiner			
326	104-106, 112,136	7/8/2005	JC			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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searche	ed above	7/8/2005	JC .	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
BRS search, IEEE Xplore search	7/8/2005	JC .			
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